

FORM PTO-1449 (modified)
To: U.S. Department of Commerce
(PW FORM PAT-1449)
Patent and Trademark Office



Atty. Dkt. No.	M#	Client Ref.
	0284163	01F181

Applicant: INABA, Satoshi

Appln. No.: 10/042,264

Filing Date: January 11, 2002

Examiner: T. DICKEY Group Art Unit: 2826

Date: July 29, 2003

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U.S. PATENT DOCUMENTS

Examiner's Initials*	Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
TH	AR 5,583,361	12/1996	Morishita			
TH	BR 5,580,799	12/1996	Funaki			
TH	CR 4,819,043	04/1989	Yazawa et al.			
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MR						
NR						

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	Document Number	Date MM/YYYY	Country	Inventor Name	English Abstract		Translation Readily Available	
					Enclosed	No	Enclose	No
TH	OR 0 962 988 A2	12/1999	Europe	Higashi et al.	X		X	
TH	PR 60-50960	03/1985	Japan	Katsuhiro	X			X
TH	QR 7-335837	12/1995	Japan	Masabumi	X			X
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TR								
UR								
VR								

OTHER (Including in this order: Author, Title, Periodical Name, Date, Pertinent Pages, etc.)

TH	WR	MIYAMOTO et al., "Pseudo-SOI: P-N-P-Channel-Doped Bulk MOSFET for Low-Voltage High Performance Applications," Electron Devices Meeting, 1998, pages 15.3.1-15.3.4		
TH	XR	MIZUNO, Tomohisa, "Analytical Model for High-Performance Shallow-Junction-Well Transistor (SJET) with a Fully Depleted Channel Structure," IEEE Transaction on Electron Devices, vol. 40, no. 1, January 1993, pages 105-111, XP 002240660		
—	YR			
—	ZR			

Examiner *TH* Date Considered: *11/04*

*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

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**INFORMATION DISCLOSURE STATEMENT
BY APPLICANT**

Date: September 15, 2003

Page **1** of **1**

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T2	WR Sze, S. M., "A Wiley-Interscience publication," ISBN 0-471-05661-8, 1981, <i>page 464</i>
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Examiner *OB* Date Considered: *01/06/04*

*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.